

INFORMATION DISCLOSURE CITATION

Atty. Docket No. 03180.0357	Application TBA No. 10801992
Applicant Hiroshi MATSUSHITA et al.	
Filing Date March 17, 2004	Group 2812 TBA Andre Steiner

U.S. PATENT DOCUMENTS

Examiner Initial*	Document Number	Issue Date	Name	Class	Sub Class	Filing Date If Appropriate
AS	2001-210097	08/03/2001	Japan	AS	AS	Abstract
AS	AS	AS	AS	AS	AS	AS
AS	AS	AS	AS	AS	AS	AS
AS	AS	AS	AS	AS	AS	AS
AS	AS	AS	AS	AS	AS	AS

FOREIGN PATENT DOCUMENTS

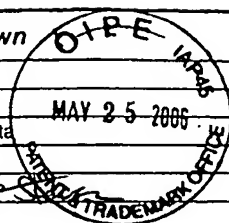
Document Number	Publication Date	Country	Class	Sub Class	Translation Yes or No
AS	2001-210097	08/03/2001	Japan	AS	AS
AS	AS	AS	AS	AS	AS
AS	AS	AS	AS	AS	AS
AS	AS	AS	AS	AS	AS
AS	AS	AS	AS	AS	AS

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

AS	Copy of U.S. Patent Application for Hiroshi MATSUSHITA et al., Serial No. 10/107,297, filed March 28, 2002
AS	Copy of U.S. Patent Application for Hiroshi MATSUSHITA, Serial No. 10/608,155, filed June 30, 2003
AS	K. Mitsutake, et al., "New Method of Extraction of Systematic Failure Component", Proc. 10 th Int. Symp. Semiconductor Manufacturing, pp. 247-250, (2001)
AS	M. Sugimoto et al., "Characterization Algorithm of Failure Distribution for LSI Yield Improvement", Proc. 10 th Int. Symp. Semiconductor Manufacturing, pp. 275-278, (2001)
AS	K. Nakamae, et al., "Fail Pattern Classification and Analysis System of Memory Fail Bit Maps", Proc. 4 th Int. Conf. Modeling and Simulation of Microsystems, pp. 598-601, (2001)

Examiner Andre Steiner	Date Considered 10/21/07
*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)			Application Number	10/801,992	
			Filing Date	March 17, 2004	
			First Named Inventor	Hiroshi Matsushita	
			Art Unit	2484 28/2	
			Examiner Name	Unknown	
Sheet	1	of	1	Attorney Docket Number	3180.0357



U.S. PATENTS AND PUBLISHED U.S. PATENT APPLICATIONS					
Examiner Initials	Cite No. ¹	Document Number	Issue or Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			
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Examiner Initials	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	Translation ⁵
		Country Code ³ Number ⁴ Kind Code ⁵ (if known)				
/	/	JP 2002-269109	9/20/02	Hitachi Ltd.	/	Abstract
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NON PATENT LITERATURE DOCUMENTS			
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/	/	Notification of Reason for Refusal issued by the Japanese Patent Office, dispatched on May 9, 2006, for Japanese Patent Application No. 2003-076411, and English-language translation thereof	/
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